

Mastering Test Generation from Smart Card Software Formal Models

Bruno LEGEARD
University of Franche-Comté & Leirios Technologies

CASSIS'04 - 12 March, 2004

Outline

➤ **Model-Based Testing**

- ✓ State of the practice in functional validation
- ✓ Main challenges in Model-Based Testing
- ✓ Leirios Test Generator: from Research to Industry

➤ **Test Generation Process for Smart Card Software**

- ✓ Modeling for Testing
- ✓ Test Generation Strategies
- ✓ Executable Test Script Generation

The State of the Practice in Functional Validation

Verifying the compliance of the application to its specifications

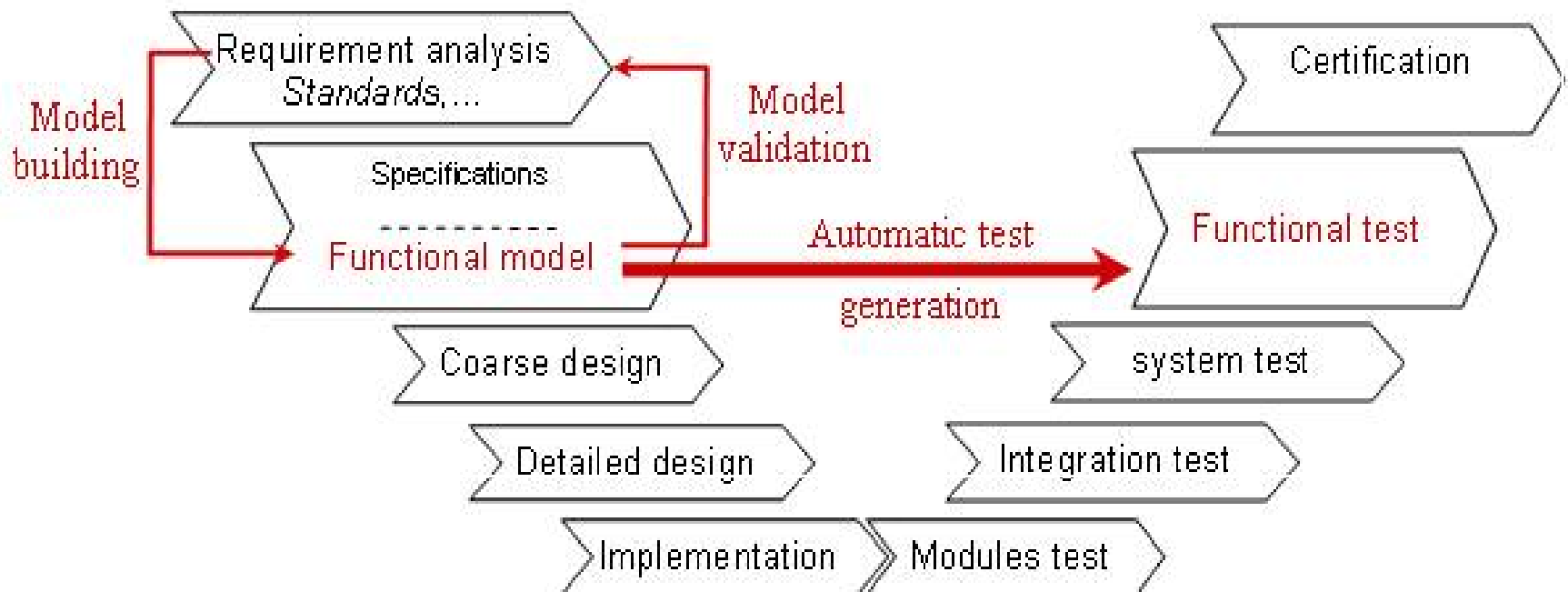
How to :

- **Specify** tests?
- Master **number** of tests?
- Find the more **relevant**?
- Optimise **functional test coverage**?
- Manage **specification change**?
- Minimize **empiricism**?

 **Automated Test Generation from a Model of the Specifications**

Model-Based Testing

Development lifecycle



Some Challenges in Automated Model-Based Testing

And how we address it?

- Mastering model complexity

→ *“Partial formal models focused on a specific feature or component of the software under test, for the sole purpose of test generation, is feasible and provide good results in a realistic industrial setting”* Farchi-Hartman-Pinter - IBM Systems Journal 41:1 - 2002

- Symbolic animation of the model

→ Using a customized set-oriented constraint solver able to compute the next system state

- Providing functional coverage of the system under test on the basis of the model

→ Test each behavior (effect) of the system with boundary input values

- Controlling the test case explosion

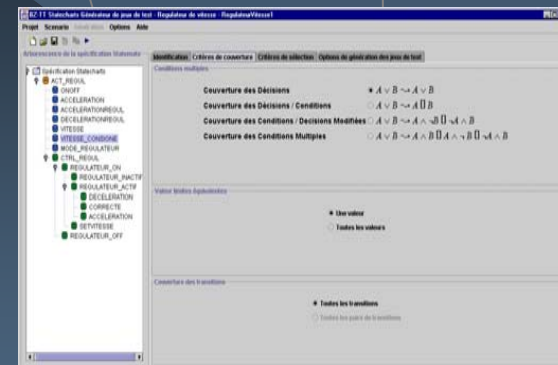
→ The validation engineer controls the test generation using model coverage criteria

LEIRIOS Test Generator: From Research to Industry

- Research in Automated Model-Based Testing since 1996 at the University of Franche-Comté (LIFC – CNRS – INRIA):
 - Based on a **symbolic animation of the formal model**
 - Use **cause-effect and boundary-testing** strategies
- Industrial applications since 1999:
 - **Smart Card area** (GSM 11-11, Java Card transaction mechanism, Key Management 2G/3G) with Axalto,
 - Urban Systems (EMV Payment, Transport Ticket) with Parkeon and G. Carte Bancaire
 - Embedded Automotive Software (wiper controller, lightings) with PSA Peugeot Citroën
- LEIRIOS Company founded in 2003 as a Spin-off of the LIFC:
 - Currently 13 R&D Engineers develop the **LEIRIOS Test Generator** – LTG – tool-set.

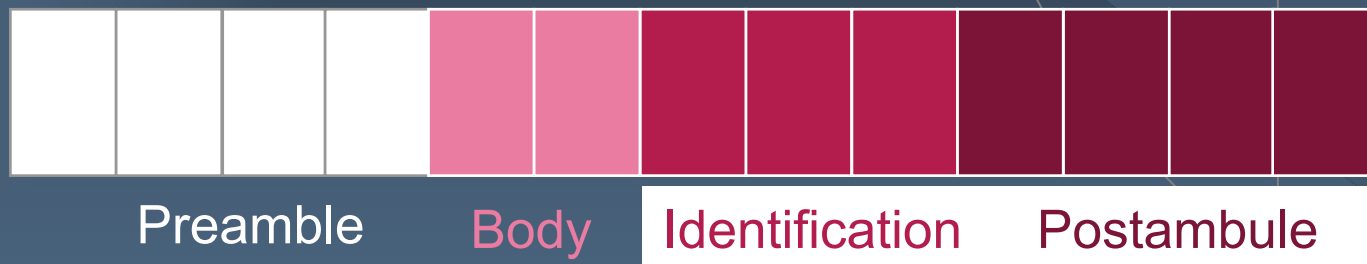
LEIRIOS Test Generator: Test Generation Principles

- Automated Boundary-Testing
 - Test each expected behavior of the system
 - Test boundary states and input values
- Generates Nominal and Robustness Test Cases
- Generates both Test Cases (with expected results) and Test Drivers → Automated diagnosis assignment
- Test Generation Driving Criteria:
 - Model coverage criteria
 - Selection criteria
 - Specification evolution



Definition of a test case

- A test case is a sequence of invocations on the system under test. It is divided in four parts:
 - Preamble: sequence of operations to reach the state to test
 - **Body**: invocation of tested effect
 - **Identification**: invocation of read-only operation to improve the expected results
 - **Postamble**: Return path to the initial state



Modeling for Testing

- LTG takes as input:
 - **B abstract machines**
 - **UML** (class and state diagrams with OCL expressions)
 - **Statecharts** Statemate
- For Smart Card OS and applications:
 - The model is developed using B or UML/OCL
 - The **abstraction level** and scope of the model depend of the test objectives
 - The model describes the **functional behavior** of the system under test

B Modeling for Test Generation

- The B abstract machine is used as a **Pseudo-Code**
- **Control-oriented** and **Data-Oriented**
- Good **abstraction** level
- ➔ Suitable for **Smart Card APDU and API modeling**

```

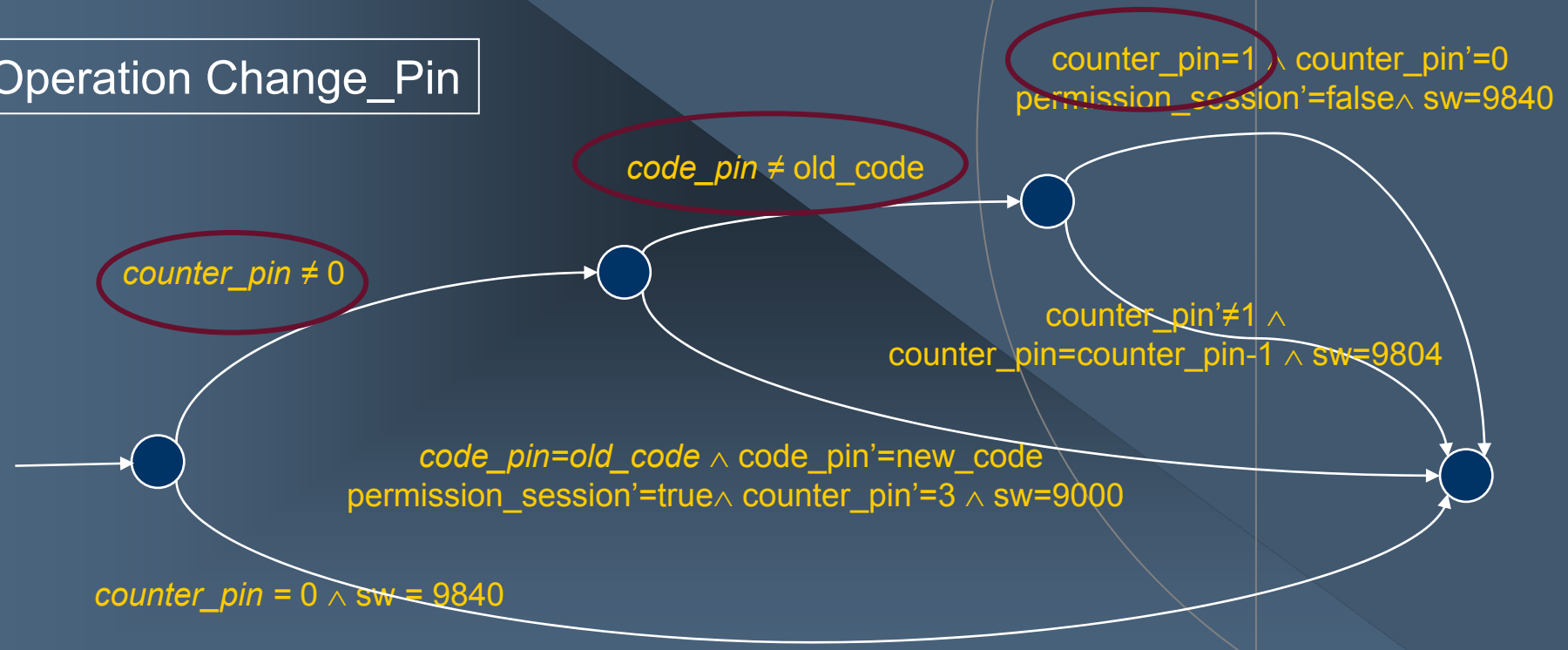
sw ← CHANGE_Pin(old_code, new_code) =
PRE
old_code ∈ Nat ∧ new_code ∈ Nat
THEN
  IF counter_pin = 0
  THEN
    sw := 9840
  ELSE
    IF code_pin = old_code
    THEN
      code_pin := new_code           ||
      counter_pin := 3               ||
      permission_session := true    ||
      sw := 9000
    ELSE IF counter_pin = 1
    THEN
      counter_pin := 0               ||
      permission_session := false    ||
      sw := 9840
    ELSE
      counter_pin := counter_pin - 1 ||
      sw := 9804
    END
  END
END END END END END ;

```

Test Generation Method

Test all effects: Invoke each **execution path** for each operation

Operation Change_Pin



Effect Predicates == $counter_pin \neq 0 \wedge code_pin \neq old_code \wedge counter_pin = 1$

Test Generation Method - Model Coverage Criteria

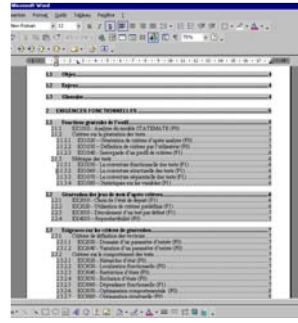
- **Multiple conditions** in the decisions criteria
 - All the Decisions (DC)
 - All the Decisions/Conditions (D/CC)
 - All the Modified Conditions / Decision (MC/DC)
 - All Multiple Conditions (MCC)
- **Symmetric value** coverage
 - One value
 - Several values
 - All values
- **Transition** coverage
 - All-Transitions
 - All-Transition-Pairs

Test Generation Algorithm

- **Step1** – Model partitioning
 - effect predicates
- **Step2 (optional)** – Boundary computation
 - boundary goals
- **Step3** – Preamble computation
 - using symbolic animation and best-first search
- **Step4** – Compute body and then identification
 - invoke tested effect predicates (or pair of tested operations)
- **Step5** – Postamble computation

Test Generation Process

Functional Model (B, Statecharts, UML/OCL)



Functional Requirements

Functional Modeling



```
MODULES
  E_Net_0
DEFINITIONS
  <Compute_ (int,yy) :=> ( (int == TRUE) ==> (yy == FALSE) ) or
  ( (int == FALSE) ==> (yy == TRUE) )
VARIABLES
  int,yy
INITIATION
  int := 0; yy := 0; Compute_ (int,yy)
FINALIZATION
  ANY
  WHEN
    int := 0; yy := 0; Compute_ (int,yy)
  THEN
    int := int || not yy
  END
OPERATIONS
  int ( int ) or
  yy ( yy ) or
  WHEN
    yy := 0; Compute_ (int,yy)
  THEN
    int := int || not yy
  END
END
END
END
END
```

Model Validation



LTG Model Animator

LTG Test Case Generator

Test Generation Criteria



Test Case Generation

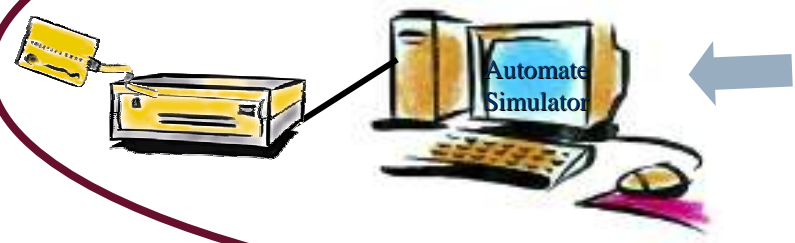
LTG Test Driver Generator

Test Cases

Test Driver Schemas



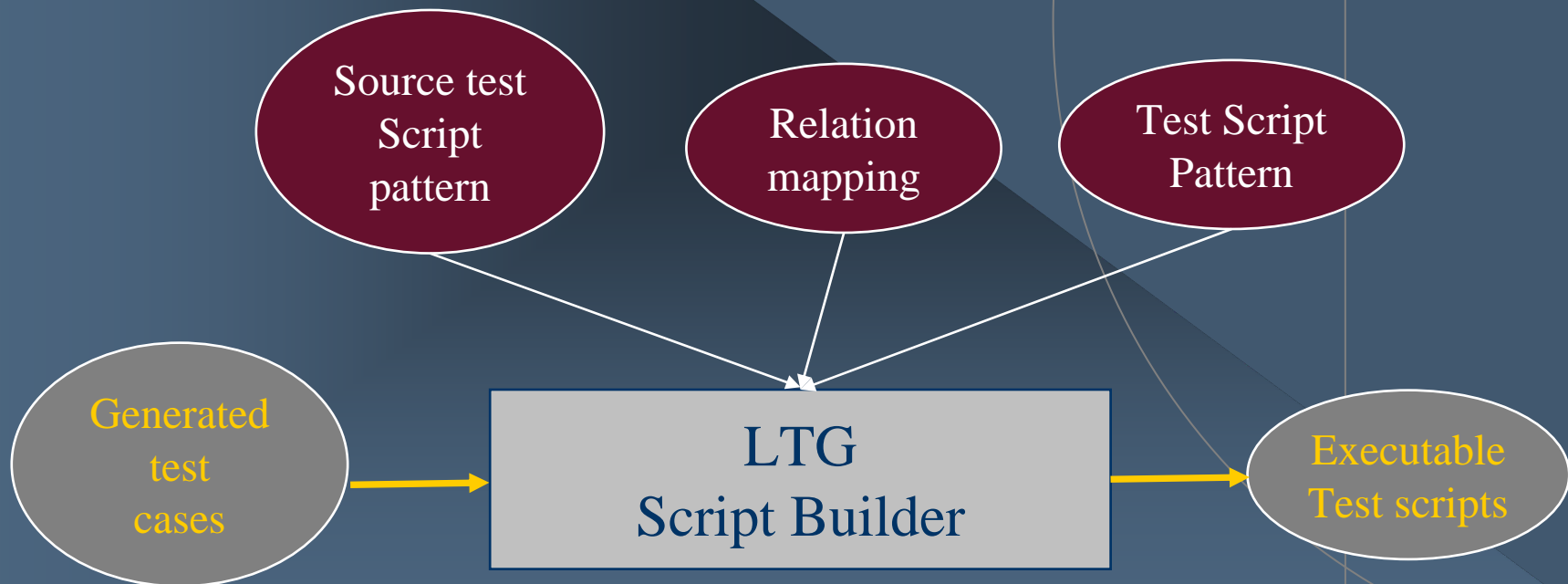
Test Driver Generation



Test Execution Environment

Executable Test Script Computation

- Use a **test script pattern** and a **relation mapping** to relate the formal (abstract) model names and the (concrete) implementation names
- Use of an observation table to link **observation procedures** with state variables
- Automates the verdict assignment – test pass/fail



Summary

- The B abstract machine notation is used as a pseudo-code to model the **data** and the **behavior** of Smart Card software
- Test cases are generated on the basis of **cause-effect** and **boundary-testing** strategies
- The test engineer controls the test case explosion using **model coverage criteria**
- Symbolic animation using constraint propagation helps to master **scalability**